FORM PTO-1449 U.S. Department of Commerce (Rev. 4/92)

Patent and Trademark Office

ATTY. DOCKET NO. APV31929

SERIAL NO. 10/577,354

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

APPLICANT Paul Alexander DE VRIES et al.

FILING DATE April 28, 2006 GROUP

### **U.S. PATENT DOCUMENTS**

EXAMINER				•								FILING DATE
NITIAL	1	_		MENT NU		9		DATE	NAME	CLASS	SUBCLASS	IF APPROPRIATE
	1	5	6	2	0		0	11/25	W. Hoopes			
	1	9	3	8	1	0	1	12/33	A.E. Hall			
	3	2	9	6	8	1	1	01/67	F.L. Stoller			
	3	3	0	3	0	1	9	02/67	S.C. Jacobs			
	3	3	0	8	6	6	6	03/67	A.R. Anderson et al.			
	3	6	7	1	2	2	9	06/72	M.E. Ferber et al.			
	3	8	3	9	0	1	9	10/74	Bruno et al.			
	3	8	4	0	3	6	4	10/74	Flemmings et al.			
	4	0	4	3	8	0	2	08/77	Esdaile et al.			
	4	0	5	0	6	8	3	09/77	Langhammer			
	4	0	9	9	9	6	5	07/78	Beguin et al.			
	4	1	3	3	5	1	7	01/79	Esdaile et al.			
	4	2	2	2	8	3	0	09/80	Dawless et al.			
	4	2	3	9	6	0	6	12/80	Dawless et al.			
	4	4	1	1	7	4	7	10/83	Dawless et al.			
	4	4	5	6	4	8	0	06/84	Wintenberger			
	4	5	8	1	0	6	2	04/86	Boutin			
	4	7	3	6	3	1	4	04/88	Riese et al.			
	4	7	4	4	8	2	3	05/88	Raymond-Seraille			
	4	7	8	1	7	7	1	11/88	Masumoto et al.			
	5	1	6	0	5	3	2	11/92	Benz et al.			
	5	7	4	1	3	4	8	04/98	Van Der Donk et al.			
	5	9	6	8	2	2	3	10/99	Eckert			
	6	1	4	3	0	7	0	11/00	Bliss et al.			
EXAMINER						DAT	E COI	NSIDERED	)			

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 U.S. Department of Commerce (Rev. 4/92) Patent and Trademark Office

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

ATTY. DOCKET NO. APV31929

APPLICANT Paul Alexander DE VRIES et al.

FILING DATE April 28, 2006

GROUP

# **U.S. PATENT DOCUMENTS**

EXAMINER INITIAL			DOCU	JMENT N	UMBER			DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	6	2	2	4	6	4	8	05/01	Verdoes et al.			
	6	2	9	0	9	0	0	09/01	Hatano et al.			
	6	3	5	5	0	8	5	03/02	Pillin et al.			

#### FOREIGN PATENT DOCUMENTS

						roi	VE10	TINIF	4 1 12 1 V 1 1	OCCUMENTS .					
				DOCU	JMENT N	UMBER			DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION		
						,		,					YES	NO	
		0	7	4	5	6	9	3	12/96	EP					
		1	2	8	8	3	1	9	03/03	EP					
		1	3	8	0	6	5	9	01/04	EP					
		7	0	7	0	6	6	6	03/95	JP			abstract only		
	5	2	1	3	5	7	9	7	11/77	JP			abstract only		
	5	5	0	5	0	4	4	2	04/80	JP			abstract only		
	5	7	1	5	2	4	3	5	09/82	JP			abstract only		
	5	8	1	0	4	1	3	2	06/83	JP			abstract only		
	5	9	0	2	8	5	3	8	02/84	JP			abstract only		
	6	0	2	3	4	9	3	0	11/85	JP			abstract only		
		2	1	0	5	0	8	4	02/98	RU			abstract only		
		1	5	9	4	1	5	4	06/70	FR				X	
EXAMINER								DATE CONSIDERED							
							•								

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 U.S. Department of Commerce (Rev. 4/92) Patent and Trademark Office	ATTY. DOCKET NO. SERIAL NO. 10/577,354				
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	APPLICANT Paul Alexander DE VRIES et al.				
(Use several sheets if necessary)	FILING DATE April 28, 2006	GROUP			

## FOREIGN PATENT DOCUMENTS

EXAMINER												TRANSLATION		
INITIAL				DOCU	MENT NI	JMBER			DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
		0	6	1	5	5	9	0	01/49	GB				
		1	3	5	2	5	6	7	05/74	GB				
		2	1	5	4	3	1	5	09/85	GB				
	20	005	0	9	5	6	5	8	10/05	WO				
		1	5	8	9	1	7	3	08/90	SU				abstract only
			2	5	8	2	8	3	07/88	DD				Mach. Trans of Abstract
		4	3	2	5	7	9	3	02/95	DE				Mach. Trans & Abstract

# OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

 OTHER DOCUMENTS (Including Matter) True, Date, 1 of timent 1 ages, Lee.)
Perry's Chemical Engineers' Handbook, 7th ed., McGraw-Hill, 1997, pp. 18-5 to 18-13.
Fourth Int'l Symposium on Recycling of Metals and Engineered Materials TMS (The Minerals, Metals, and Materials Society) 2000, pp. 979-991, Refining of a 5xxx Series Aluminium Alloy Scrap by ALCOA Fractional Crystallization Process, by Ali Unal.
US Published Patent Appln. No. 2001/0031823 A1, (Appln. No. 09/728,706), Atchetee et al., Filed December 1, 2000, Published October 18, 2001.
US Published Patent Appln. No. 2004/0261572 A1, (Appln. No. 10/488,042), De Vries, Filed August 30, 2002, published December 30, 2004.
US Published Patent Appln. No. 2006/0162491 A1, (Appln. No. 10/516,889), De Vries et al., Filed June 27, 2003, Published July 27, 2006.
US Published Patent Appln. No. 2005/0178239 A1, (Appln. No. 10/516,888), De Vries et al., Filed June 27, 2003, Published August 18, 2005.
US Published Patent Appln. No. 2005/0039578 A1, (Appln. No. 10/491,278), De Vries et al., Filed Oct 2, 2002, Published Feb. 24, 2005.
Unpublished Patent Appln. No. 10/598,731, De Vries, Filed September 8, 2006.
US Published Patent Appln. No. 2007/0023110 A1, (Appln. No. 11/492,226), De Vries et al., Filed July 25, 2006, Published Feb. 1, 2007.

EXAMINER DATE CONSIDERED

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. (Form PTO-1449 [6-4